

Notice of References Cited

Application/Control No.

10/589,766

Applicant(s)/Patent Under
Reexamination
BEUN ET AL.

Examiner

JEREMIAH AVERY

Art Unit

2431

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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